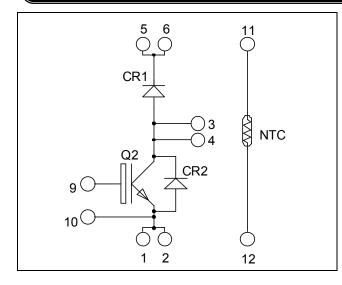
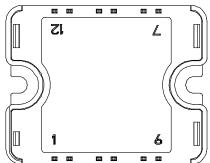
Boost chopper High speed Trench + Field Stop IGBT4 Power Module







Pins 1/2; 3/4; 5/6 must be shorted together

Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

Features

- High speed Trench + Field Stop IGBT 4 Technology
 - Low voltage drop
 - Low leakage current
 - Low switching losses
- Very low stray inductance
- Internal thermistor for temperature monitoring

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- **RoHS Compliant**

All ratings (a) $T_i = 25$ °C unless otherwise specified

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V_{CES}	Collector - Emitter Voltage		1200	V
Ţ	Continuous Collector Current	$T_C = 25^{\circ}C$	170	
I_{C}		$T_C = 80$ °C	100	Α
I_{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	340]
V_{GE}	Gate – Emitter Voltage		±20	V
P_{D}	Power Dissipation		520	W

😘 🕬 Tion: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1200V$				50	μΑ
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$	1.78	2.05	2.42	V
$V_{CE(sat)}$	Conector Emitter Saturation Voltage	$I_{\rm C} = 100A$	$T_j = 150$ °C		2.6		v
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 3.8 \text{ mA}$		5.1	5.8	6.4	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	= 0V			150	nA

Dynamic Characteristics

Symbol	Characteristic	Test Condition	ns	Min	Typ	Max	Unit	
Cies	Input Capacitance	$V_{GE} = 0V$			6150			
C_{oes}	Output Capacitance	$V_{CE} = 25V$			460		pF	
C_{res}	Reverse Transfer Capacitance	f = 1MHz			345			
Q_{G}	Gate charge	$V_{GE} = 15V, I_{C}$ $V_{CE} = 960V$	= 100A		460		nC	
$T_{d(on)}$	Turn-on Delay Time	Inductive Swit	tching (25°C)		30			
T_{r}	Rise Time	$V_{GE} = \pm 15V$			57			
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 100A$			290		ns	
T_{f}	Fall Time	$R_G = 5\Omega$		16				
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C)			30			
T_{r}	Rise Time	$V_{GE} = \pm 15V$			49			
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 600 \text{V}$ $I_{\text{C}} = 100 \text{A}$			366		ns	
T_{f}	Fall Time	$R_G = 5\Omega$			48			
Eon	Turn on Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 600V$	$T_j = 150$ °C		9.5		mJ	
E_{off}	Turn off Energy	$\begin{array}{c c} I_C = 100A \\ R_G = 5\Omega \end{array} \qquad T_j = 150^{\circ}C$			5.6		1113	
R_G	Integrated gate resistor				7.5		Ω	
I_{sc}	Short Circuit data	$V_{GE} \le 15V$; $V_{Bus} = 600V$ $t_p \le 10 \mu s$; $T_1 = 150 ^{\circ} C$			350		A	
R_{thJC}	Junction to Case Thermal Resistance					0.29	°C/W	

Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					1200	V
I_{RM}	Reverse Leakage Current	$V_R = 1200V$				100	μΑ
I_F	DC Forward Current		Tc = 60°C		100		A
		$I_F = 100A$			2.4	3.5	
V_{F}	Diode Forward Voltage	$I_F = 150A$			2.7		V
		$I_{\rm F} = 100A$	$T_j = 125$ °C		1.8		
4	D Time		$T_j = 25$ °C		385		
t_{rr}	Reverse Recovery Time	$I_{\rm F} = 100 A$	$T_{j} = 125^{\circ}C$		480		ns
0	Reverse Recovery Charge	$V_R = 800V$ $di/dt = 200A/\mu s$	$T_j = 25$ °C		1.05		μС
Q_{rr}			$T_{j} = 125^{\circ}C$		5.24		
R_{thJC}	Junction to Case Thermal Resistance	•	•			0.35	°C/W



IGBT parallel diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					1200	V
I_{RM}	Reverse Leakage Current	V _R =1200V				100	μΑ
I_{F}	DC Forward Current		$Tc = 70^{\circ}C$		30		A
		$I_{\rm F} = 30A$			2.6	3.5	
V_{F}	Diode Forward Voltage	$I_F = 60A$			3.2		V
		$I_F = 30A$	$T_{j} = 125^{\circ}C$		1.8		
4	t_{rr} Reverse Recovery Time $I_F = 30A$		$T_j = 25$ °C		300		***
ι_{rr}			$T_{j} = 125^{\circ}C$		360		ns
0	$V_R = 800V$ di/dt = $200A/\mu s$	$\int di/dt - 200 \Lambda / us \qquad T_i = 3$	$T_j = 25$ °C		360		
Ųп		•	$T_{j} = 125^{\circ}C$		1700		пC
R_{thJC}	Junction to Case Thermal Resistance					1.2	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta \mathrm{B/B}$		T _C =100°C		4		%

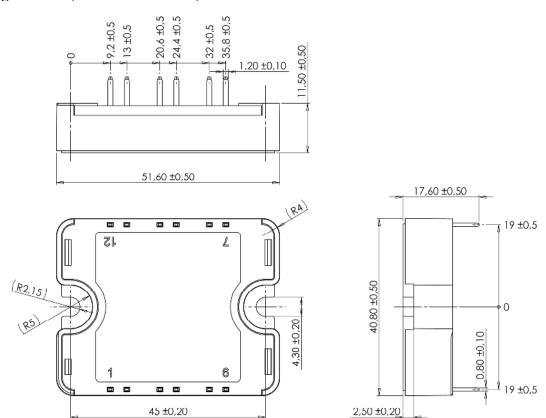
$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature R_T: Thermistor value at T

Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case	t = 1 min, 50/60)Hz	4000		V
T_{J}	Operating junction temperature range	-40	175			
T_{JOP}	Recommended junction temperature under switching conditions			-40	T _J max -25	°C
T_{STG}	Storage Temperature Range				125	
$T_{\rm C}$	Operating Case Temperature			-40	125	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				80	g



Package outline (dimensions in mm)

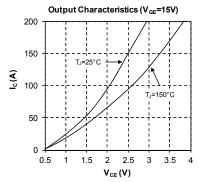


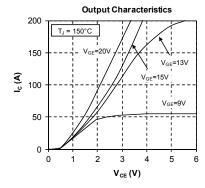
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

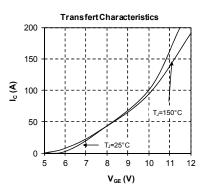


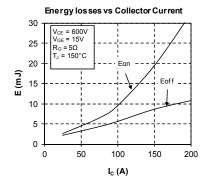
Power Matters."

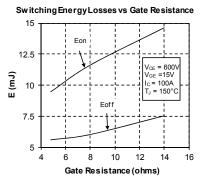
Typical IGBT & chopper diode performance curves

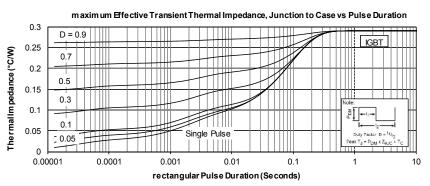






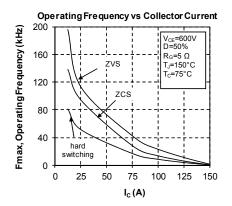


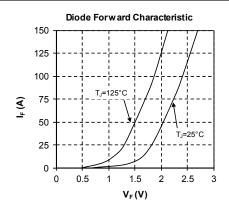




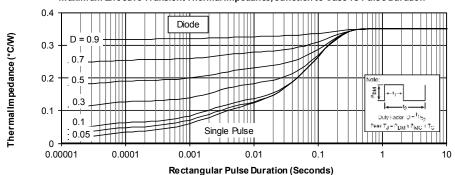


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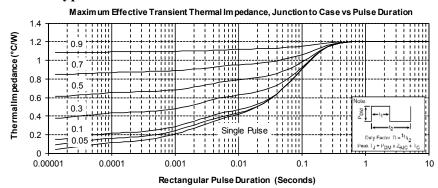


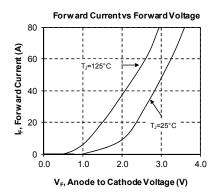


maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



IGBT parallel diode Typical Performance Curves





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